Search	Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/640,609	NAKAYAMA ET AL.	
Examiner	Art Unit	
Aung S. Mae Lin /e	2618-2622	

SEARCHED				
Class	Subclass	Date	Examiner	
348	223.1	11/11/2006	ASM	
	224.1			
	225.1			
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348	655	11/13/2006	ASM '	
348	223.1	2/28/07	Ŋ	
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INTERFERENCE SEARCHED				
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	Subclass	Subclass Date		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST searched	11/11/2006	ASM	
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